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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/652,841	08/31/2000	Vishnu K. Agarwal	98-0616.02	4006
27076	7590	01/28/2005	EXAMINER	
DORSEY & WHITNEY LLP INTELLECTUAL PROPERTY DEPARTMENT SUITE 3400 1420 FIFTH AVENUE SEATTLE, WA 98101			DIAZ, JOSE R	
			ART UNIT	PAPER NUMBER
			2815	
DATE MAILED: 01/28/2005				

Please find below and/or attached an Office communication concerning this application or proceeding.

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APPLICATION NO./ CONTROL NO.	FILING DATE	FIRST NAMED INVENTOR / PATENT IN REEXAMINATION	ATTORNEY DOCKET NO.
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EXAMINER

ART UNIT	PAPER
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20040113

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Commissioner for Patents

The information disclosure statement filed December 9, 2004 fails to comply with 37 CFR 1.97(d) because it lacks a statement as specified in 37 CFR 1.97(e). It has been placed in the application file, but the information referred to therein has not been considered.


GEORGE ECKERT
PRIMARY EXAMINER

Sheet 1 of 1

FORM PTO-1449 (REV.7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 501082.03		APPLICATION NO. 09/652,841	
INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>				APPLICANT(S) Vishnu K. Agarwal			
				FILING DATE August 31, 2000		GROUP ART UNIT 2815	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
AA	5,858,831	01/12/99	Sung	438	241		
AB	5,963,826	10/05/99	Takanabe et al.	438	622		
AC	6,010,931	01/04/00	Sun et al.	438	240		
AD	6,081,010	06/27/00	Sanchez	257	345		
AE	6,114,200	09/05/00	Yew et al.	438	253		
AF	6,146,959	11/14/00	DeBoer et al.	438	393		
AG							
AH							
AI							
AJ							
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
AK							
AL							
AM							
AN							
AO							
OTHER PRIOR ART <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>							
AP							
AQ							
AR							
EXAMINER 				DATE CONSIDERED 11/13/04			
<p>* EXAMINER: Initial if reference considered, whether or not criteria is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).</p>							